Search Notes



Application/Cont	rol	No.

10/612,766 Examiner

Luan K. Bui

Applicant(s)/Patent under Reexamination

YEWDALL ET AL.

Art Unit

3728

SEARCHED				
Class	Subclass	Date	Examiner	
206	438-441	12/19/2005	LKB	
	560, 565			
220	216, 326			
	221-227			
	788,795			
	202			
	203.01			
602	41, 48			
	54			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
		=		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	